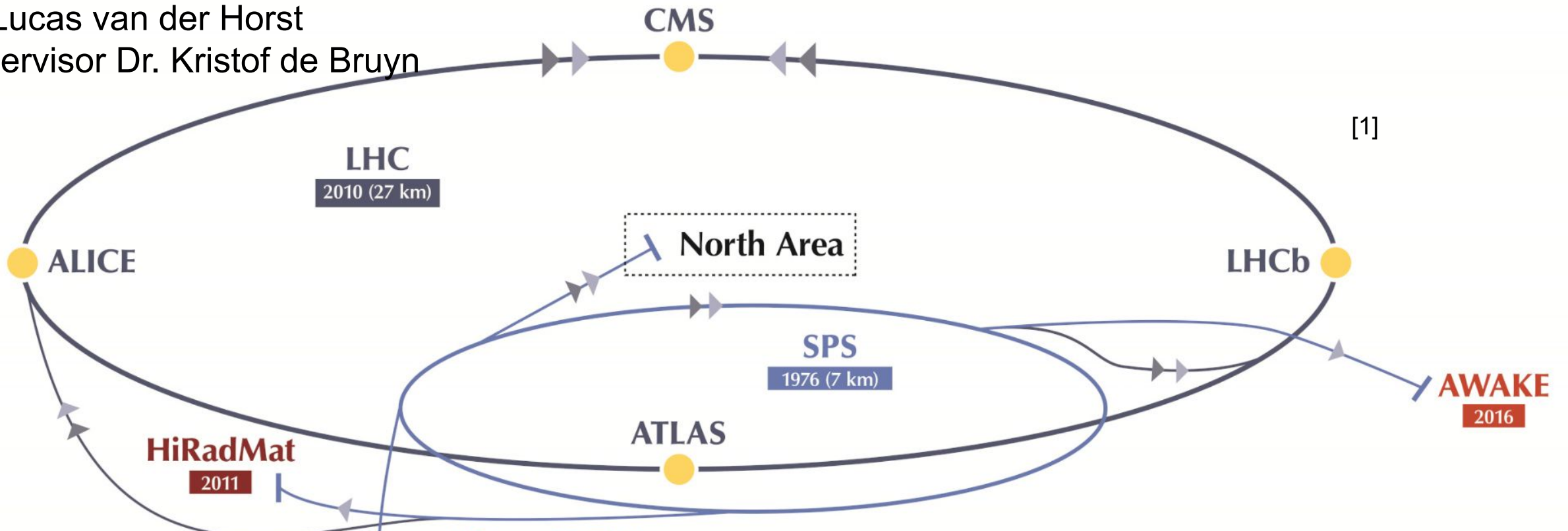




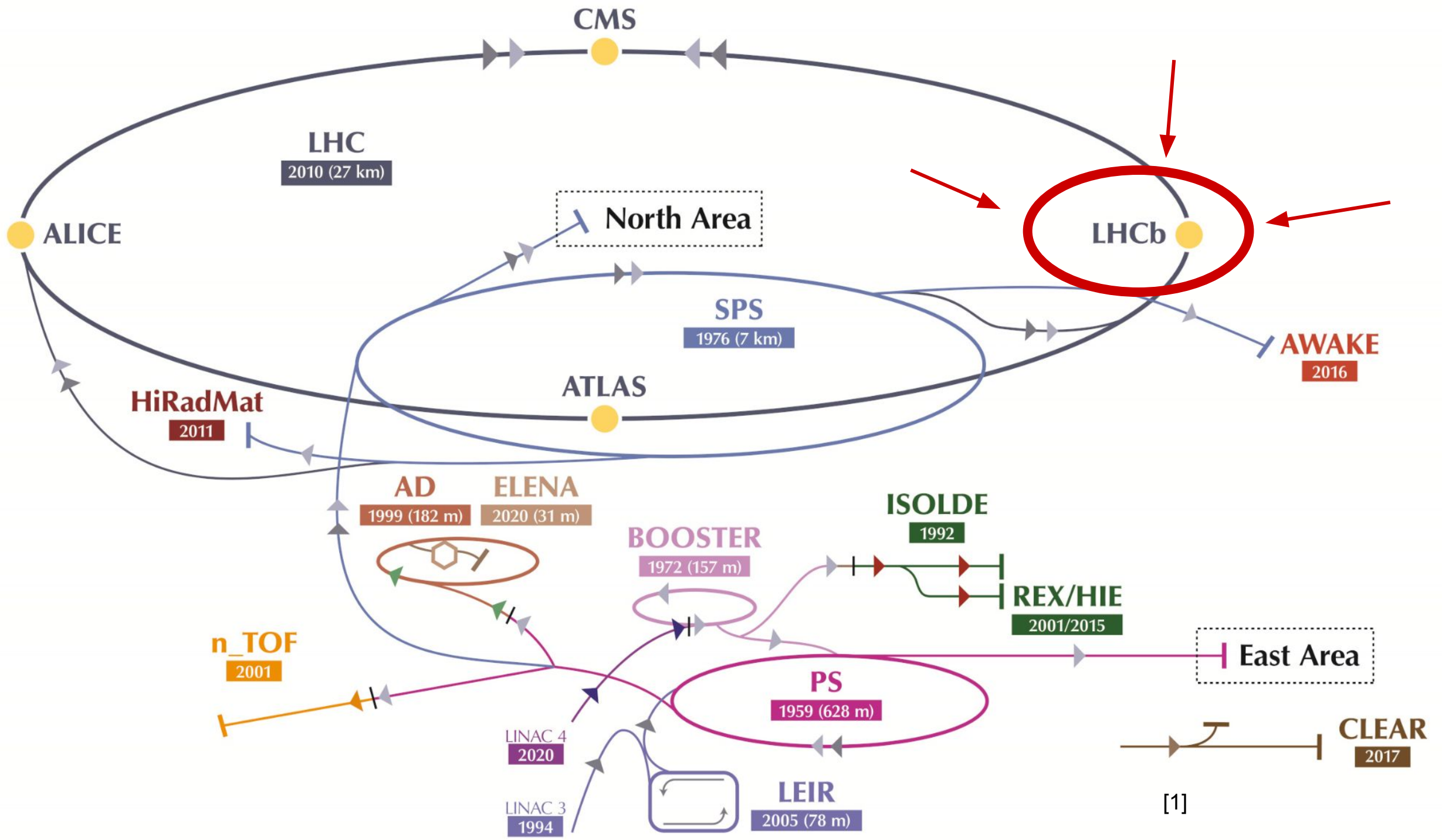
# Heterogeneity of VELO's pixel response to a monochromatic radiation Fe55 source

By Lucas van der Horst  
Supervisor Dr. Kristof de Bruyn

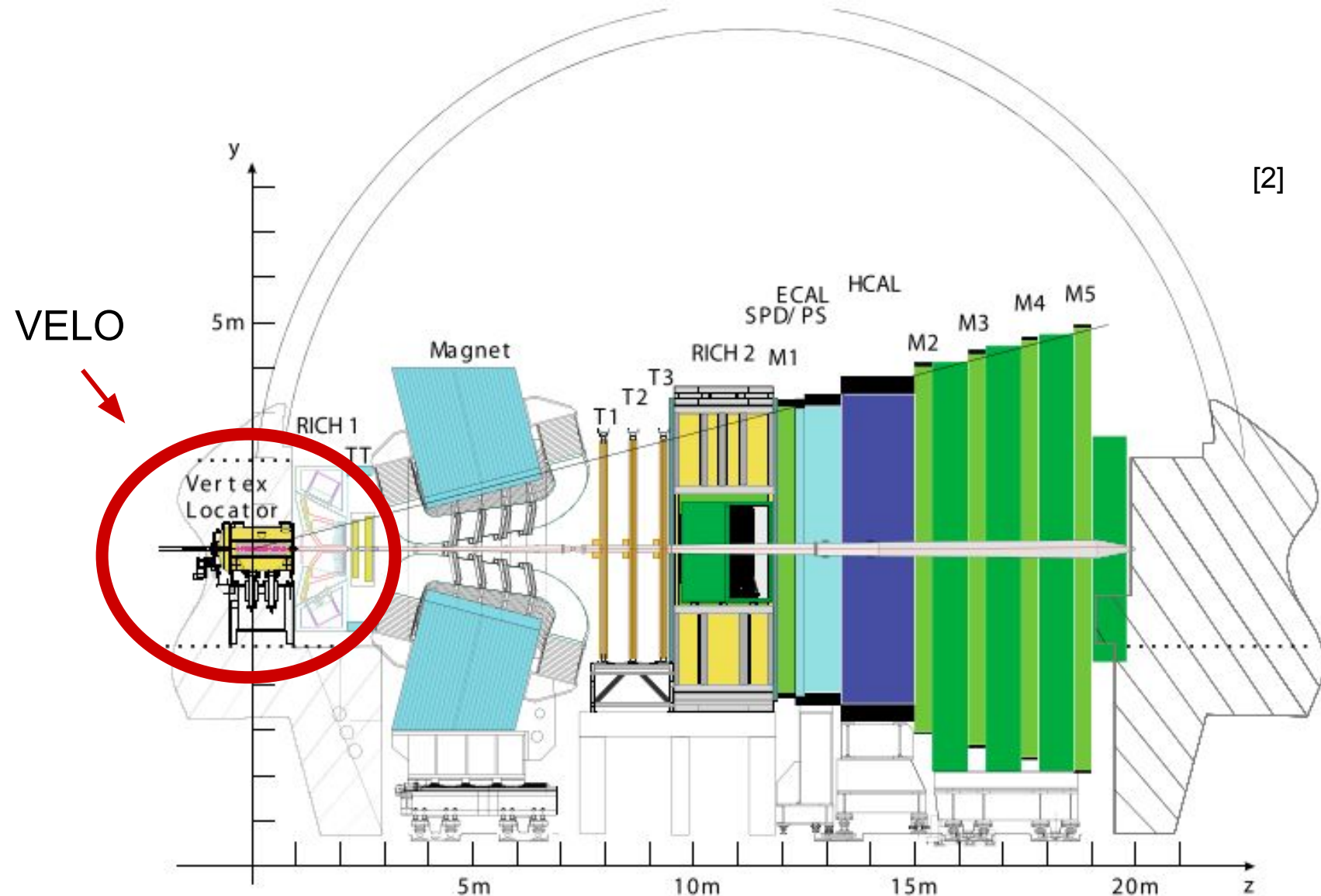


To study the  
fundamentals of  
the universe,  
CERN is founded  
in 1954



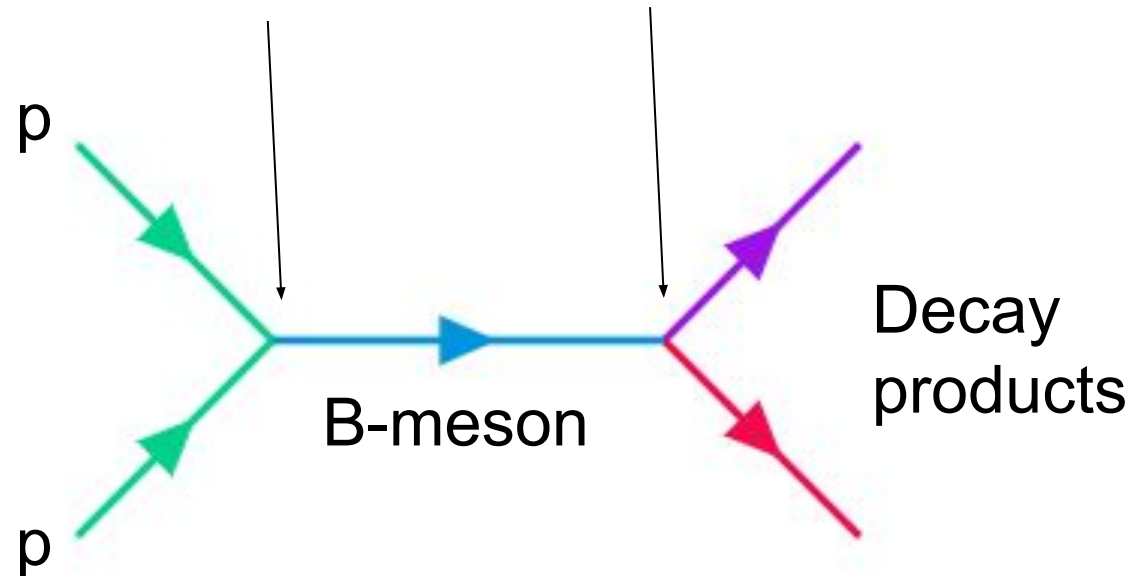


Studying  
the matter  
antimatter  
asymmetry

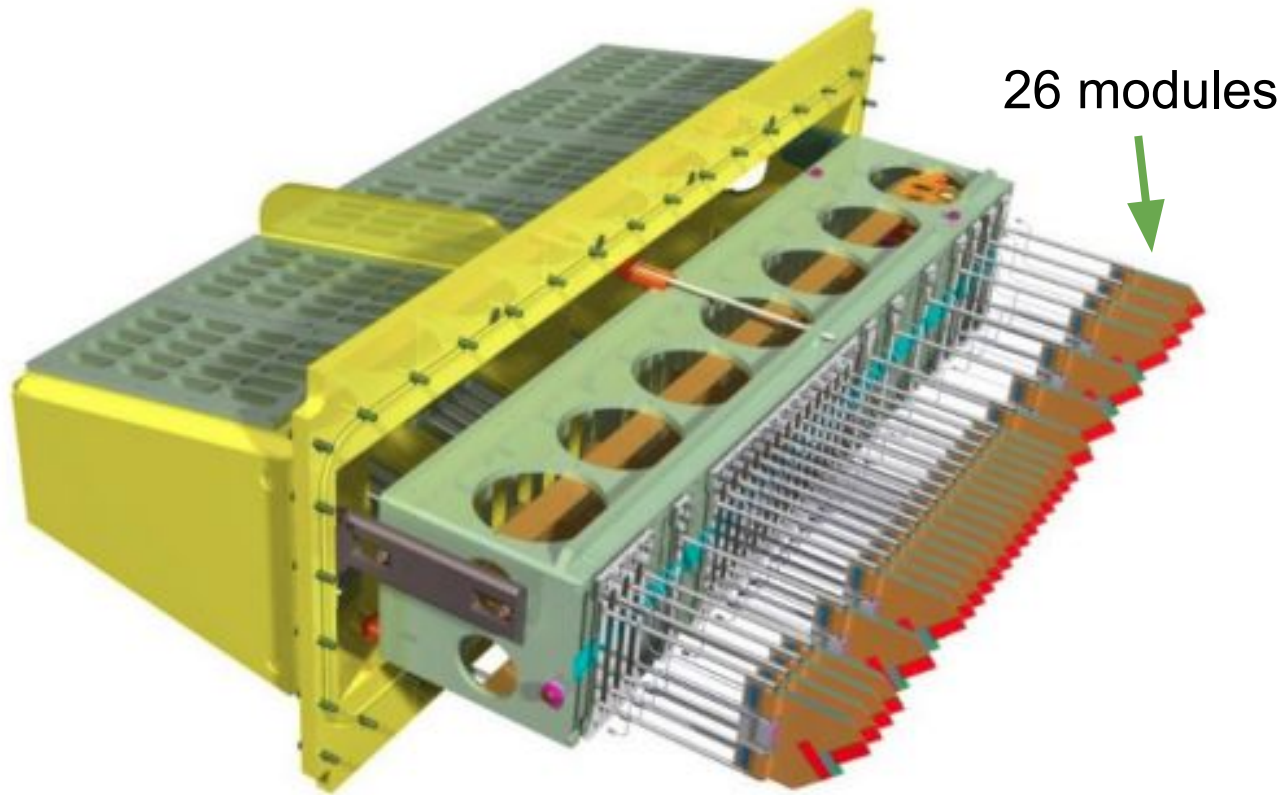


To measure the passing of charged particles

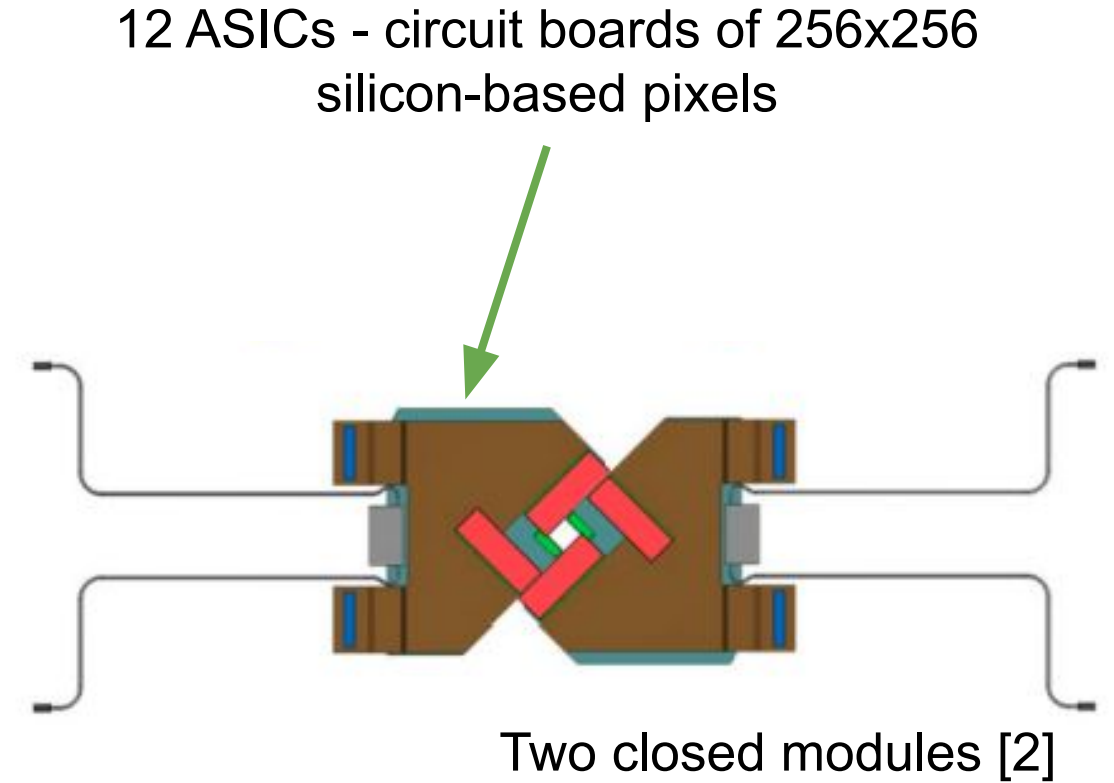
From this: impact parameters, primary and secondary vertices







Half of the upgraded VELO detector [2]





- Charged particles ionize silicon
- Creating a measurable charge
- Pixel registers hit if charge  $>$  set threshold

Next step:

- Calibrate pixels using monochromatic radiation Fe55 source  
 threshold scan

However,

- Pixel are not identical:
  - Manufacturing variations
  - Impurities
  - Electronics



How does the response of the pixels to the Fe55 source threshold scan compare to that of the average pixel?

- If any, what is the nature of their difference?
- Are longer exposure times required for proper calibration?



Threshold energy

Charge sharing

Energy of radiated particles

Spectrum

Detector's resolution

Normal distribution

$$I(E) = f \cdot \frac{1}{2} \operatorname{erfc} \left( \frac{E - E_0}{s} \right) + (1 - f) \cdot \frac{1}{s\sqrt{2\pi}} e^{-\frac{1}{2} \left( \frac{E - E_0}{s} \right)^2}$$

Integrating  $I(E)$  from  $E$  to infinity:

$$F(E) = Af \cdot \frac{1}{2} \left( \frac{s}{\sqrt{\pi}} e^{-\left(\frac{E-E_0}{s}\right)^2} + (E_0 - E) \cdot \operatorname{erfc} \left( \frac{E - E_0}{s} \right) \right) + A(1 - f) \cdot \frac{1}{s\sqrt{8\pi}} \cdot \operatorname{erfc} \left( \frac{E - E_0}{s\sqrt{2}} \right)$$

Particle flux  
 spectrum

Normalization  
 factor

VELO exposed to monochromatic (5.19keV) radiation (electrons) Fe55 source for a range of different thresholds

Four data sets available, hits stored in 256x256 matrices:  
2nd and 4th data sets have largest exposure times

In this presentation, 2nd data set is considered

- › Initial masking (faulty pixels)
- › Elimination of bad acquisitions (strange behaviour)
- › Trimming of thresholds where no hits were measured
- › Mask pixel if no hits were measured for more than 80% of the thresholds
- › Compute particle flux



- › Fit  $F(E)$  to spectrum of average pixel
  
- › Fit  $F(E)$  to spectra of each pixel
  - Fixing the fitting parameters except for  $A$  to those obtained from average pixel
  - Free fit
  
- › Chi-square test for goodness of fit

# Results

## Spectra

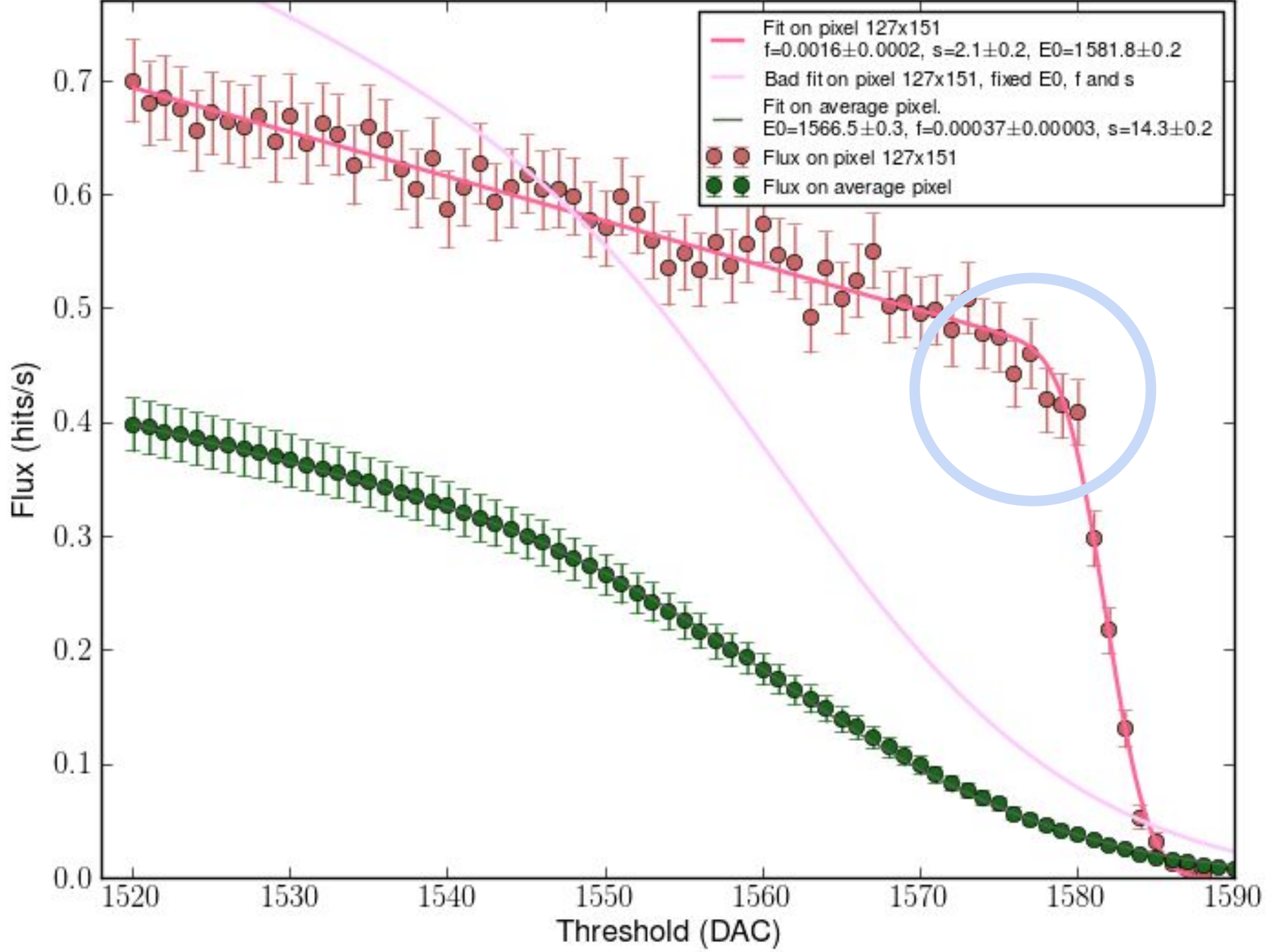
Pixel 127x151

2nd data set

 Sharp drop

Pixel of center, hot region. Higher flux than average

Free fit performs better



# Results

## Spectra

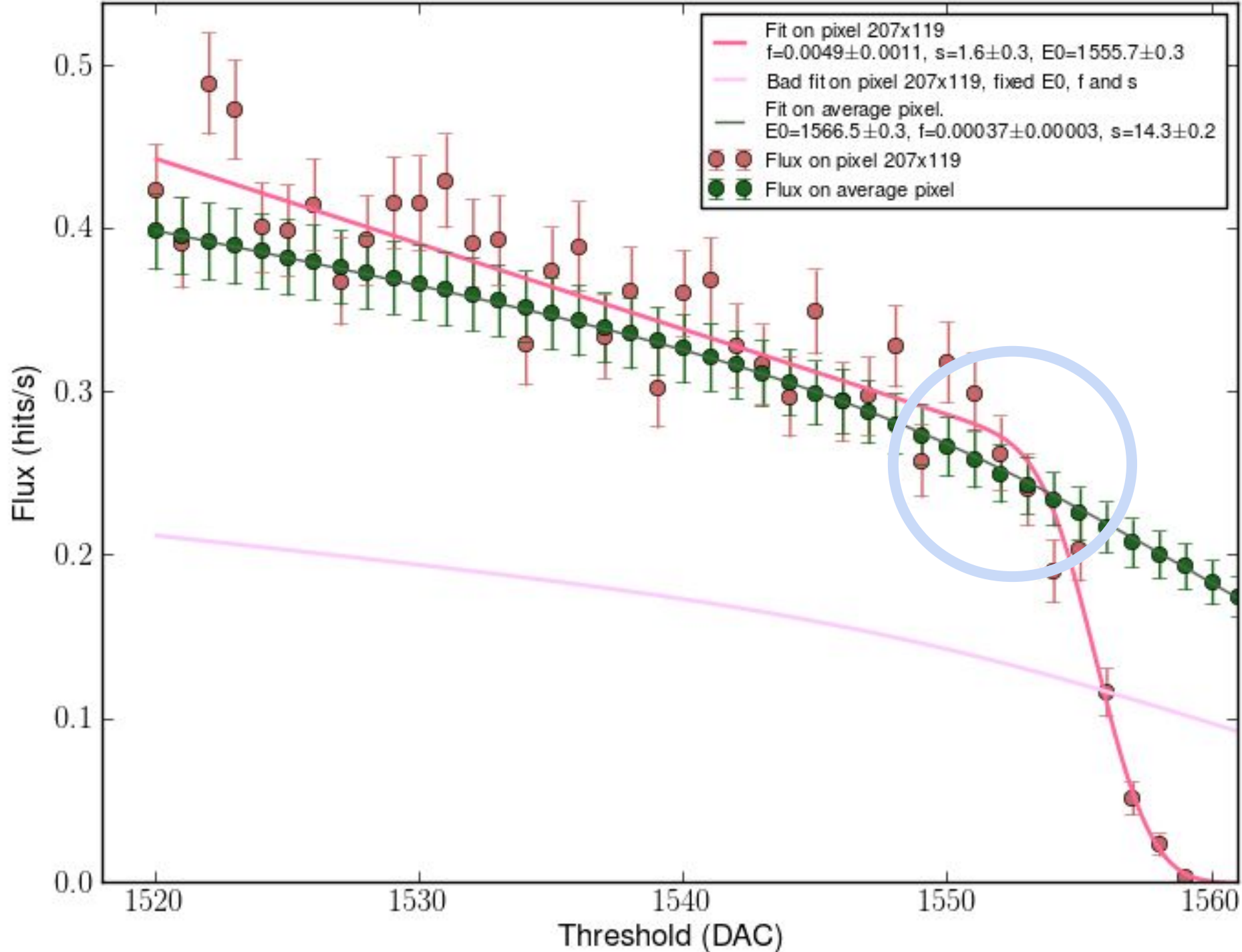
Pixel 207x119

2nd data set

○ Sharp drop

Pixel further from center, colder region.  
Flux matches average

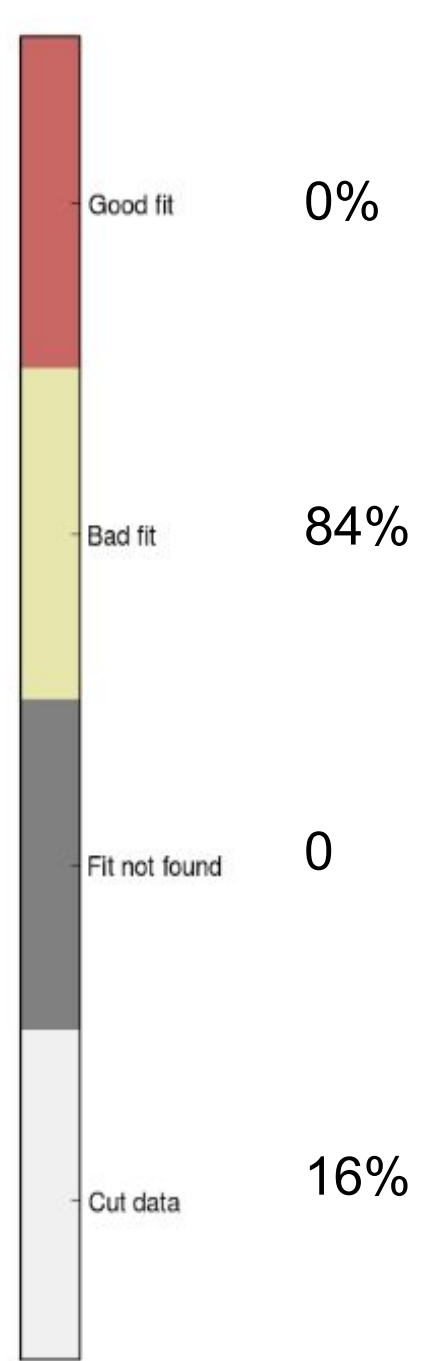
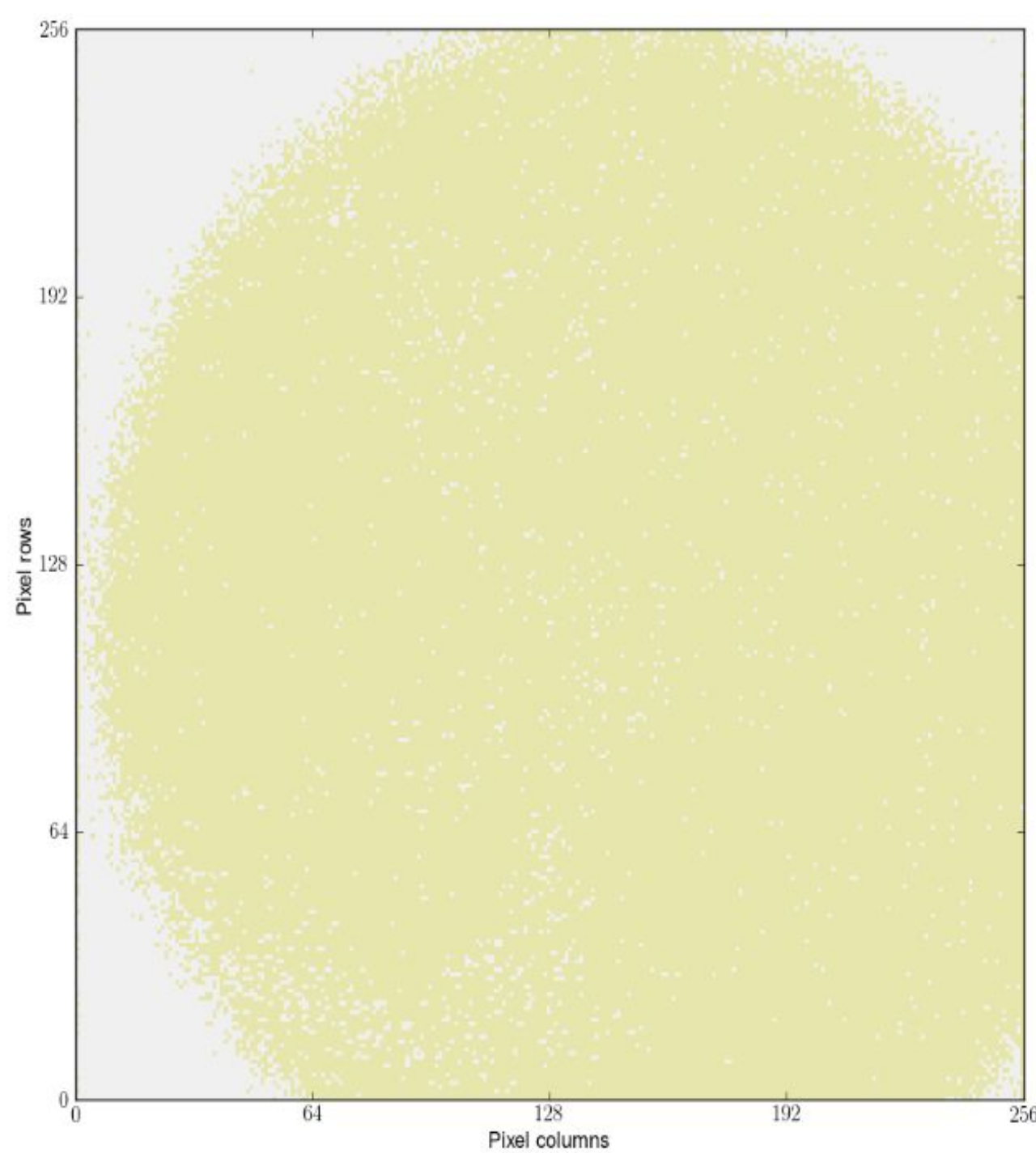
Free fit performs better



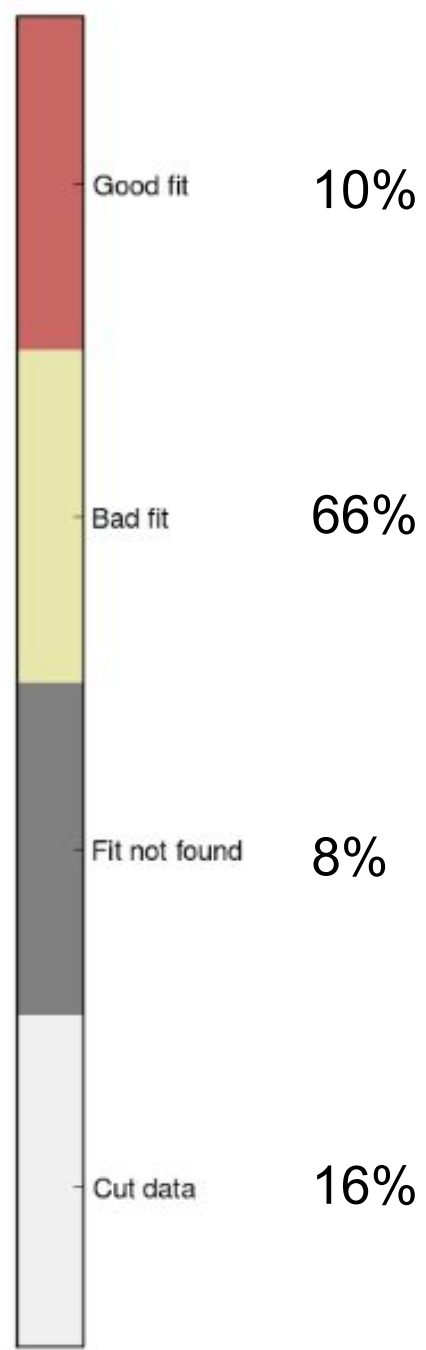
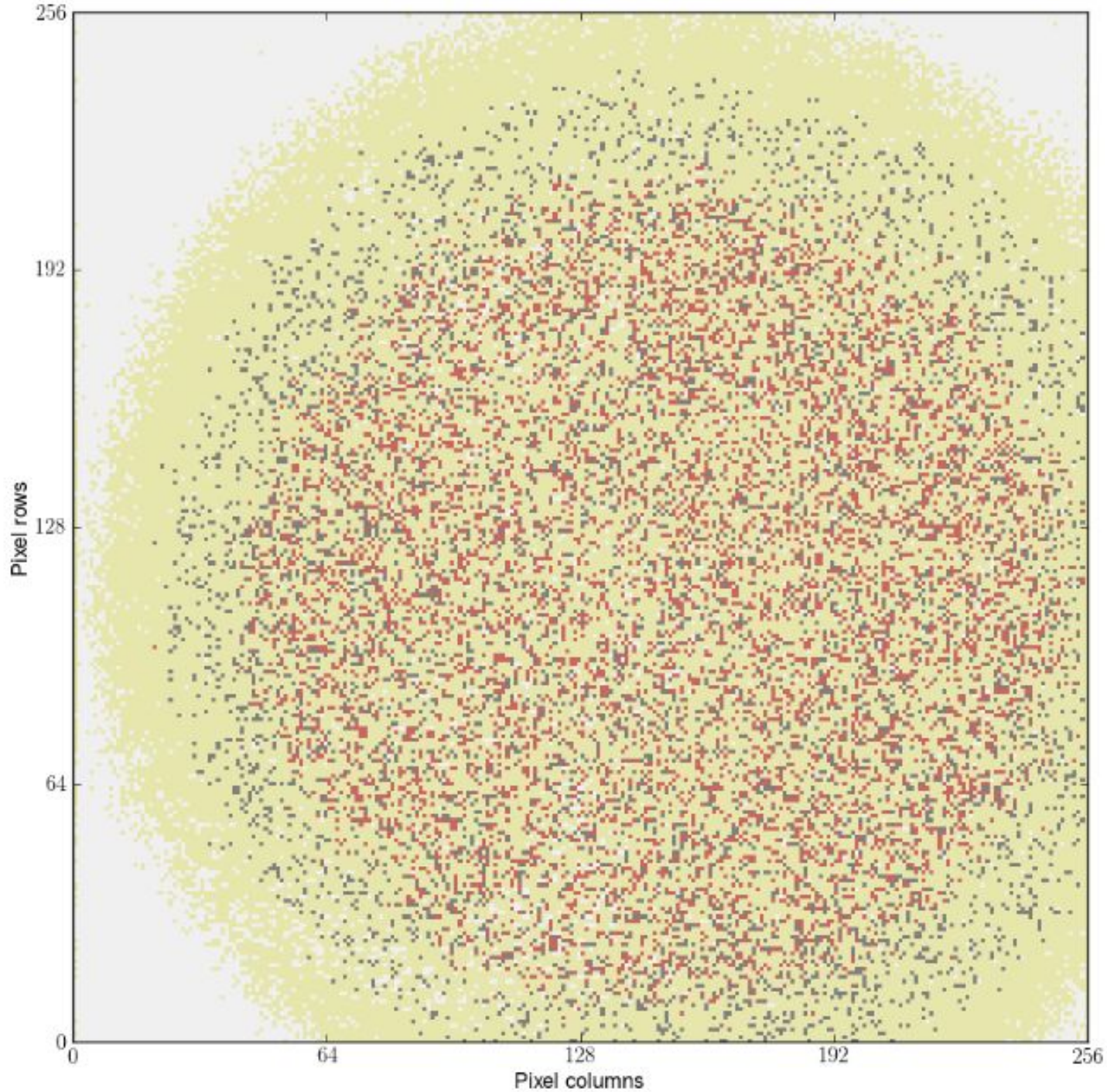
# Results

Fixed fit type  
2nd data set

None of the fits pass  
the chi-square test







# Results

Free fit type

2nd data set

10% of fits pass  
chi-square test,  
concentrated in the hot  
region



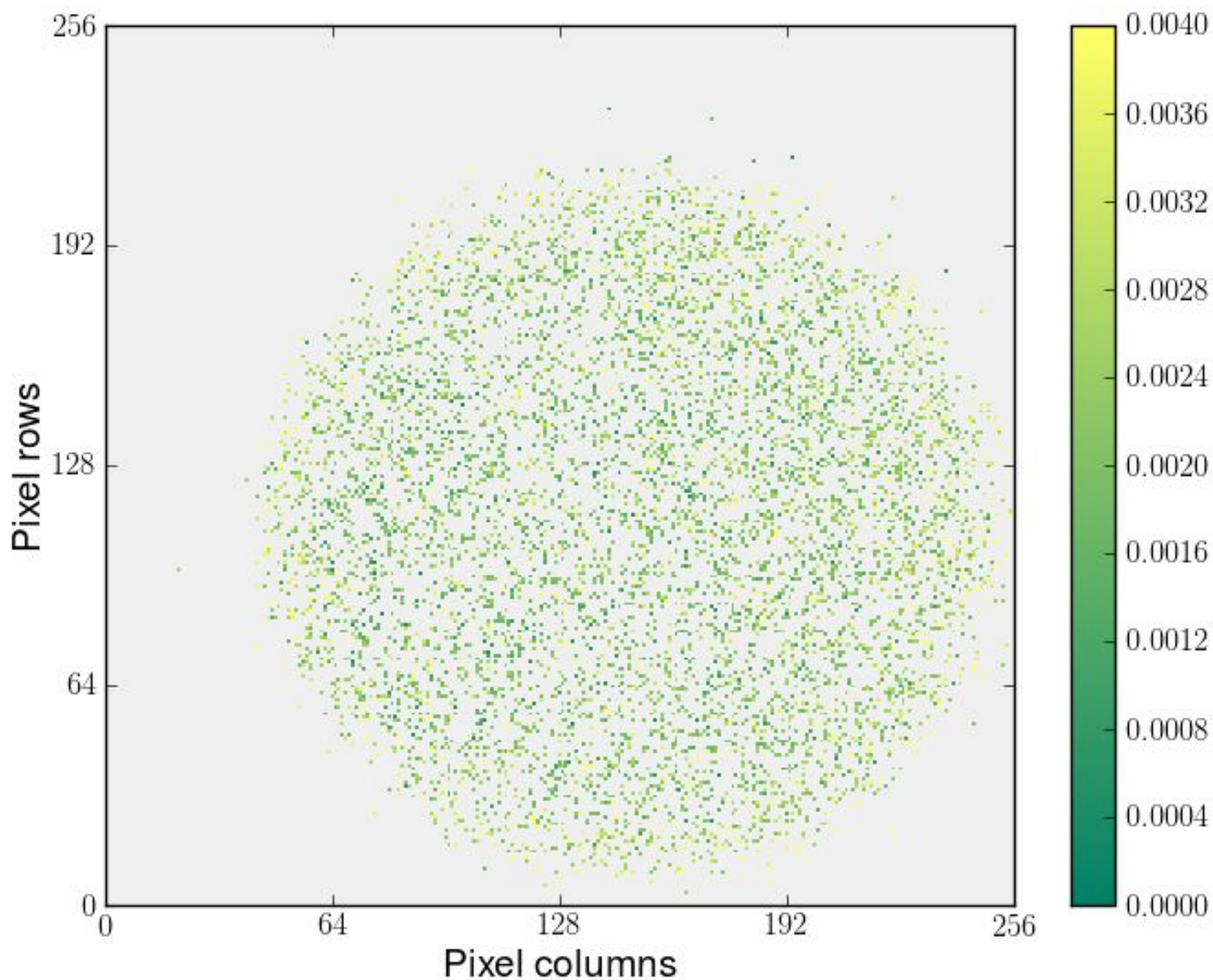
# Results

$f$  heatmap

2nd data set

$f$  values are 1 order of magnitude higher than for the spectrum of the average pixel

Values possibly in accordance with predictions from [3]





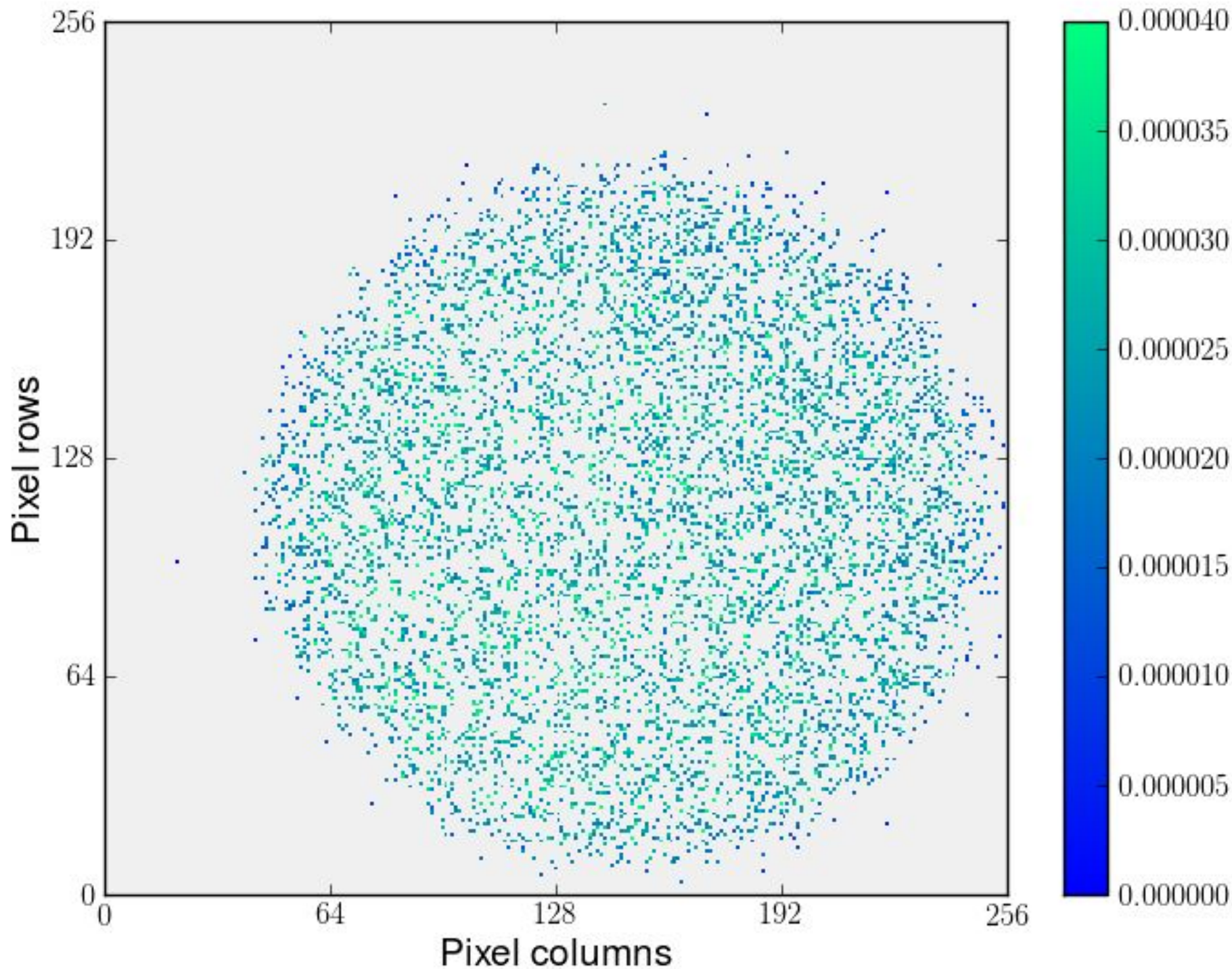
# Results

$s$  heatmap

2nd data set

$s$  values are 6 order of magnitude higher than for the spectrum of the average pixel

Drop in spectra explained by low resolution  $\rightarrow$   $s$  parameter controls that feature



- The response of single pixels differs from the average pixel
  - ◆ Notable flux drop for higher but not equal thresholds
    - Due to low resolution
    - Feature vanishes when averaged
  - ◆ Free fit works much better than fixed fit

- The response of single pixels differs from the average pixel
  - ◆ Notable flux drop for higher but not equal thresholds
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  - ◆ Free fit works much better than fixed fit
  
- A lot of data cut and failed chi-square test for lack of hits (exposure time)
  - ◆ 2nd data set had 14.5h total exposure time. More is needed

- [1] CERN. <https://panoramas-outreach.cern.ch/index.html>. Accessed: 28/06/2023.
- [2] K. Hennessy, “LHCb VELO upgrade,” Nuclear Instruments and Methods in Physics Research Section A: Accelerators, Spectrometers, Detectors and Associated Equipment, vol. 845, pp. 97–100, feb 2017.
- [3] K. Mathieson et al. , “Charge sharing in silicon pixel detectors,” Nuclear Instruments and Methods in Physics Research Section A: Accelerators, Spectrometers, Detectors and Associated Equipment, vol. 487, no. 1-2, pp. 113–122, 2002.



# Results

## Spectra

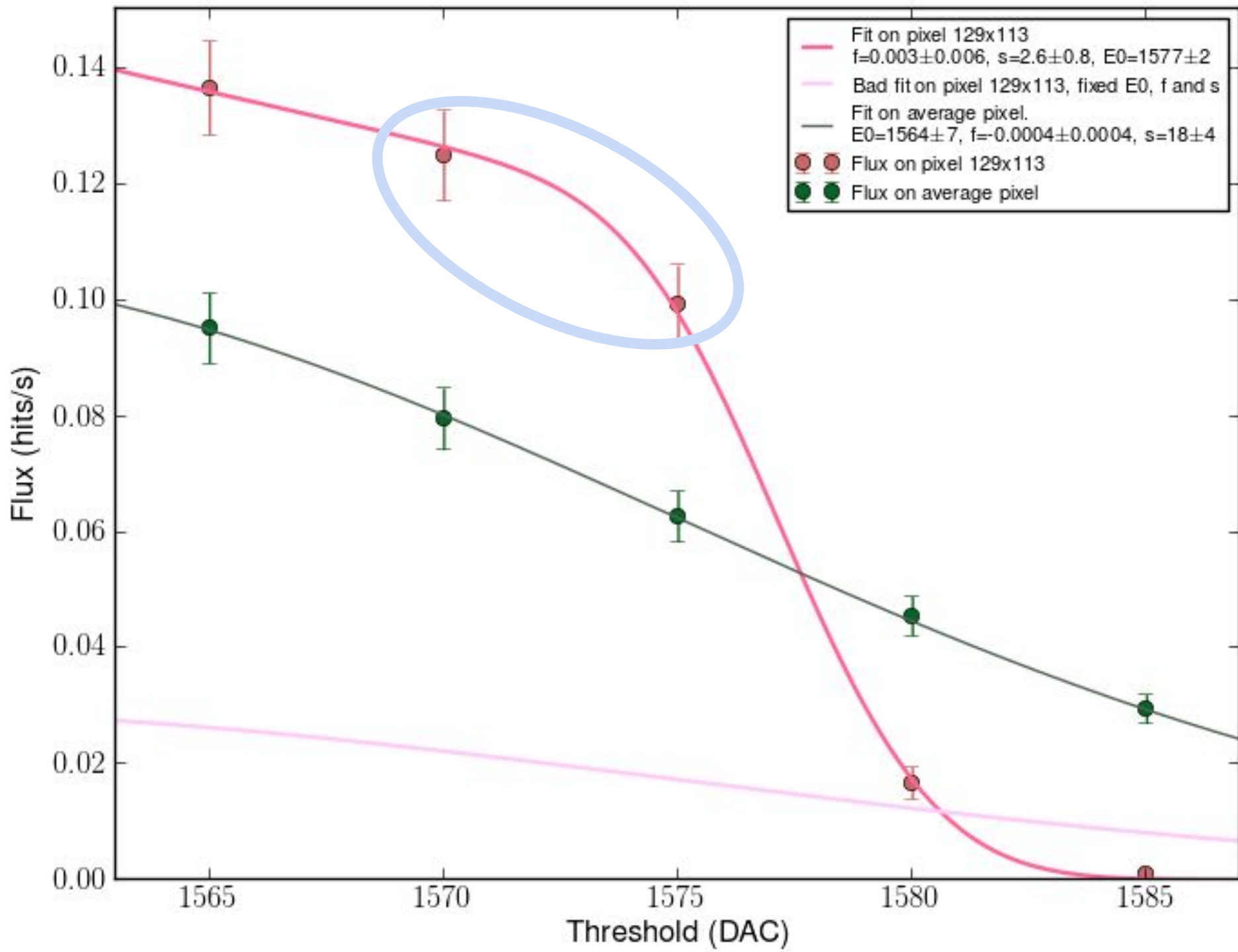
Pixel 129x113

4th data set

 Sharp drop

Pixel of center, hot region

Free fit performs better





# Results

## Spectra

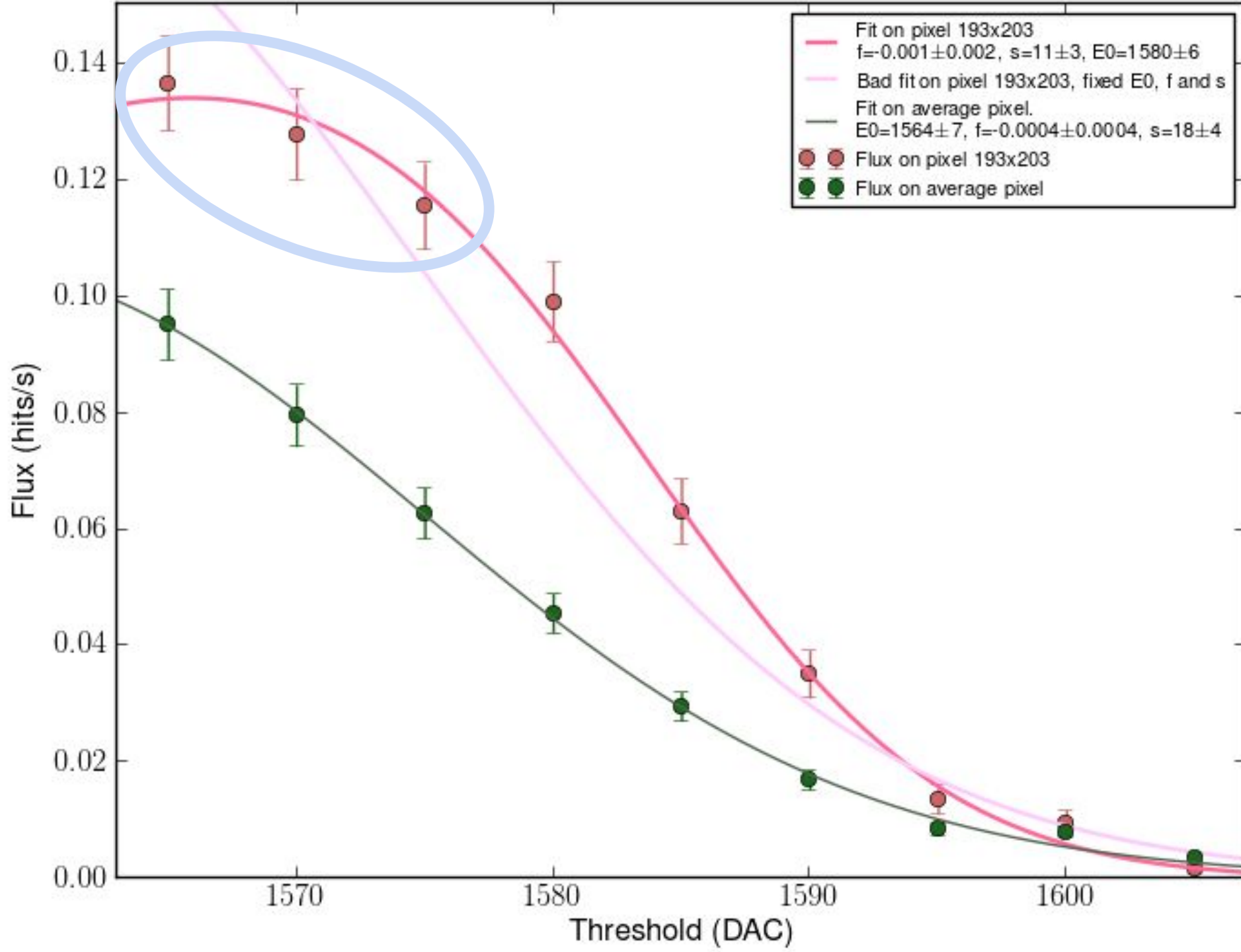
Pixel 193x203

4th data set

 Sharp drop

Pixel further from center, colder region.

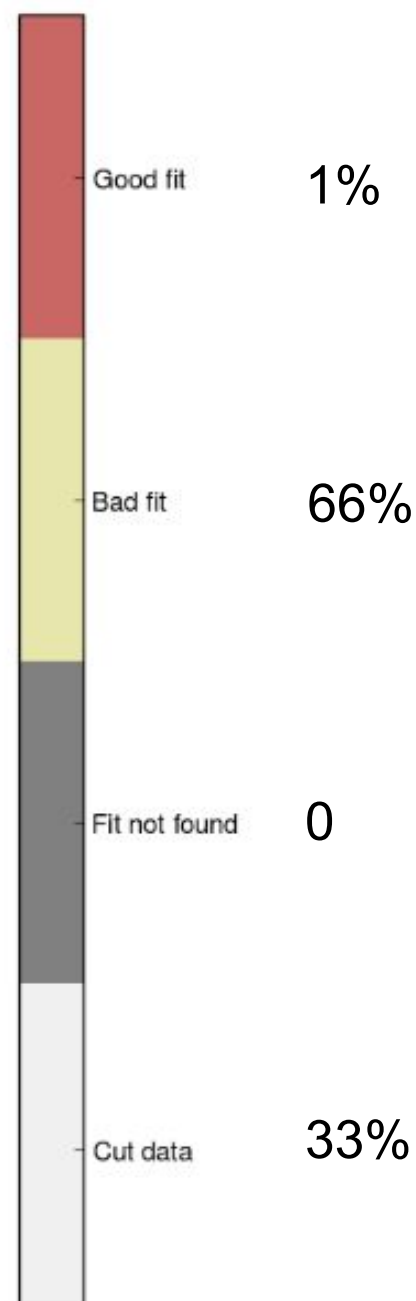
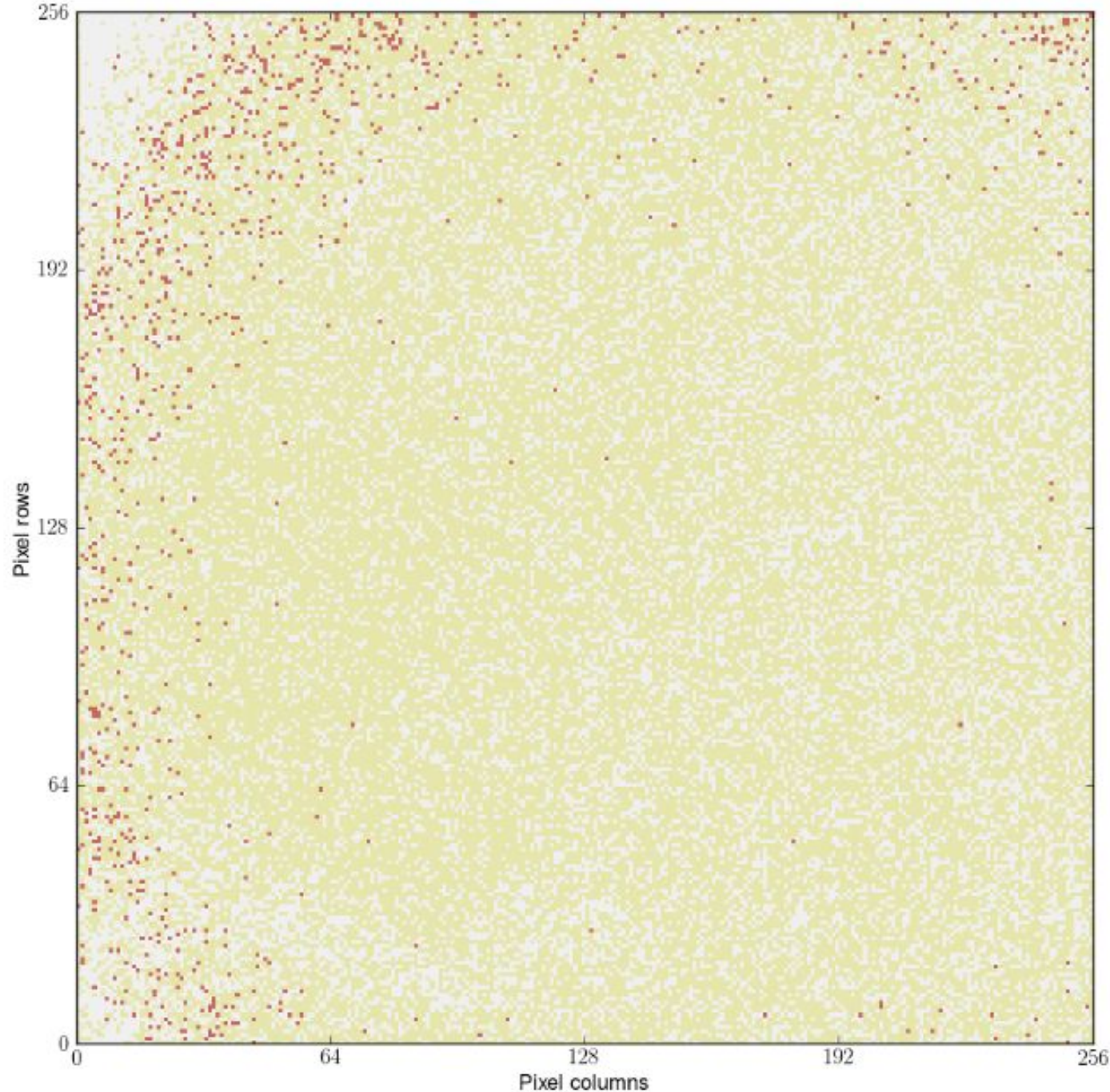
Free fit performs better



# Results

Fixed fit type

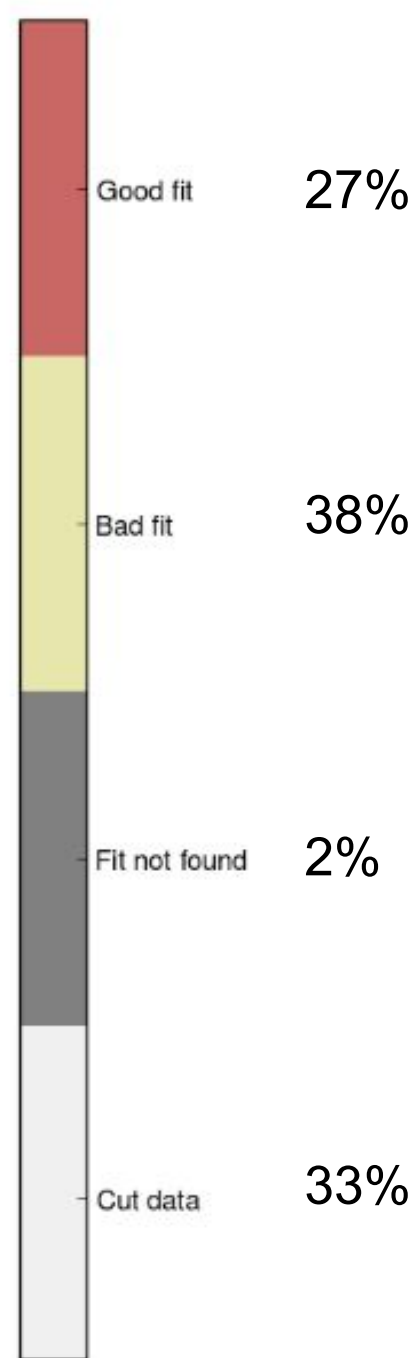
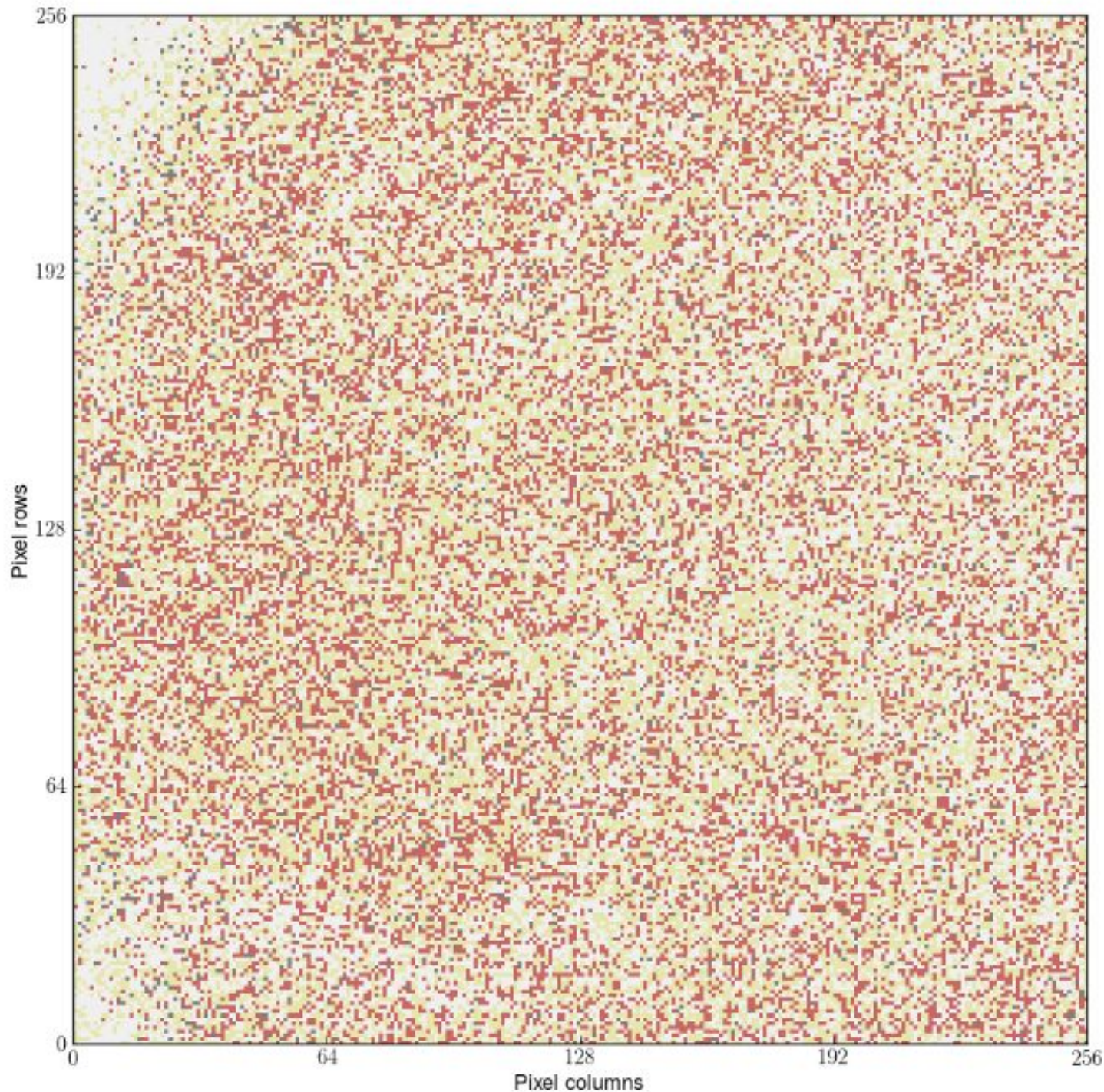
4th data set



Only 1% have a good fit

Hot region is larger than 2nd data set → source is further away





# Results

Free fit type

4th data set

27% of fits pass  
chi-square test

Hot region spans the  
entire grid

35h total exposure  
time